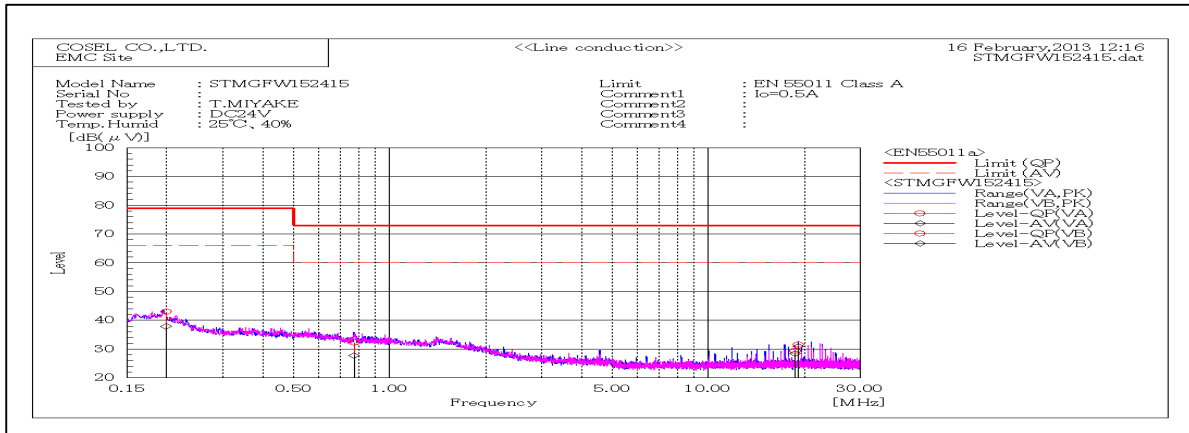
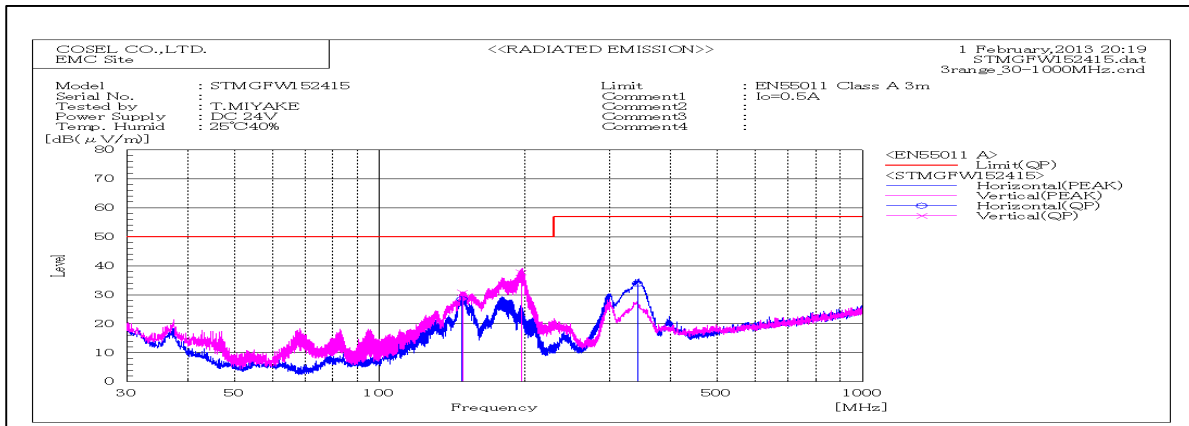


DATA SHEET		Date	18-Feb-13
Model	STMGFW152415	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Miyake



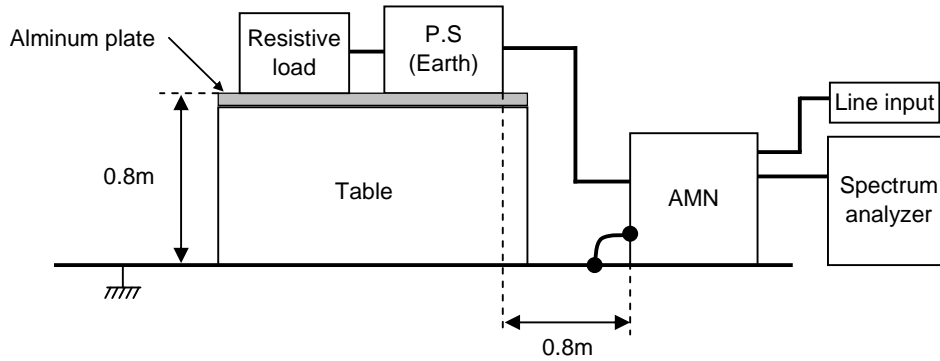
Frequency MHz	Harm	Line Phase	Reading dB(uV)		Factor dB	Level dB(uV)		Limit dB(uV)		Margin dB		Pass/Fail	Remark
			QP	AV		QP	AV	QP	AV	QP	AV		
0.19899		VA	22.8	17.7	20.2	43	37.9	79	66	36	28.1	Pass	
0.77337		VA	12.2	7.6	20.1	32.3	27.7	73	60	40.7	32.3	Pass	
18.65455		VB	8.2	7.2	21.2	29.4	28.4	73	60	43.6	31.6	Pass	
19.1101		VA	10.4	9.7	21.2	31.6	30.9	73	60	41.4	29.1	Pass	



Frequency MHz	Polarization	Stability	Reading dB(uV)		Space Loss dB	Level dB(mW)		Limit dB(mW)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	AV		QP	QP						
148.093	H	Stable	48.8	-20.3	28.5	50	21.5	50	21.5	Pass	154	248	
148.56	V	Stable	48.5	-17.8	30.7	50	19.3	50	19.3	Pass	108	307	
196.728	V	Stable	53.5	-15.8	37.7	50	12.3	50	12.3	Pass	105	282	
341.867	H	Stable	47.5	-13.7	33.8	57	23.2	57	23.2	Pass	108	100	

DATA SHEET		Date	18-Feb-13
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Miyake

1. Line conduction



2. Radiated emission

